


<b>Search Notes</b> 	<b>Application/Control No.</b> 10720125	<b>Applicant(s)/Patent Under Reexamination</b> FUJITA ET AL.
	<b>Examiner</b> LEILA MALEK	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	285,296,260,299	7/29/2008	L.M.
332	159,162	7/29/2008	L.M.
455	63.1	7/29/2008	L.M.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST,IEEE,Inventor Name Search, Consulted M. Ghayour	7/29/2008	L.M.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	296,260,299	7/29/2008	L.M.
332	159,162	7/29/2008	L.M.
455	63.1	7/29/2008	L.M.